

STGB30H60DF STGP30H60DF

30 A, 600 V field stop trench gate IGBT with Ultrafast diode

Target specification

Features

- Very high speed switching
- Tight parameters distribution
- Safe paralleling
- Low thermal resistance
- 6 µs short-circuit withstand time
- Ultrafast soft recovery antiparallel diode

Applications

■ Motor control

Description

This device is an IGBT developed using an advanced proprietary trench gate and field stop structure. This IGBT is the result of a compromise between conduction and switching losses, maximizing the efficiency of high switching frequency converters. Furthermore, a slightly positive V_{CE(sat)} temperature coefficient and very tight parameter distribution result in easier paralleling operation.

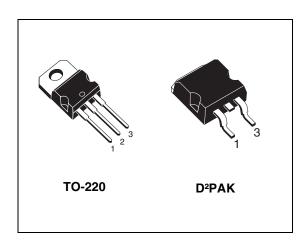


Figure 1. Internal schematic diagram

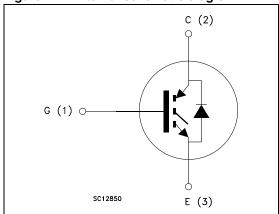


Table 1. Device summary

Order code	Marking	Package	Packaging
STGB30H60DF	GB30H60DF	D²PAK	Tape & reel
STGP30H60DF	GP30H60DF	TO-220	Tube

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage (V _{GE} = 0)	600	V
I _C	Continuous collector current at T _C = 25 °C	60	Α
Ic	Continuous collector current at T _C = 100 °C	30	Α
I _{CP} ⁽¹⁾	Pulsed collector current	120	Α
V _{GE}	Gate-emitter voltage	±20	V
I _F	Diode RMS forward current at T _C = 25 °C	30	Α
I _{FSM}	Surge not repetitive forward current t _p = 10 ms sinusoidal	90	Α
P _{TOT}	Total dissipation at T _C = 25 °C	150	W
t _{SC}	Short-circuit withstand time at V_{CC} = 400 V, V_{GE} = 15 V	6	μs
T _{STG}	Storage temperature range - 55 to 150		°C
TJ	Operating junction temperature	- 33 10 130	

^{1.} Pulse width limited by maximum junction temperature and turn-off within RBSOA

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thJC}	Thermal resistance junction-case IGBT	0.83	°C/W
R _{thJC}	Thermal resistance junction-case diode	2.5	°C/W
R _{thJA}	Thermal resistance junction-ambient	62.5	°C/W

2 Electrical characteristics

 $T_J = 25$ °C unless otherwise specified.

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector-emitter breakdown voltage (V _{GE} = 0)	I _C = 2 mA	600			٧
	Callector amitter acturation	V _{GE} = 15 V, I _C = 30 A		1.9		
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_{C} = 30 \text{ A}$ $T_{J} = 125 ^{\circ}\text{C}$		2.0		V
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_C = 1 \text{ mA}$		6.0		٧
I _{CES}	Collector cut-off current (V _{GE} = 0)	V _{CE} = 600 V			TBD	μΑ
I _{GES}	Gate-emitter leakage current (V _{CE} = 0)	V _{GE} = ± 20 V			TBD	nA

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies} C _{oes} C _{res}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{CE} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GE} = 0$	-	4200 120 75	-	pF pF pF
Qg	Total gate charge		-	115	-	nC
Q _{ge}	Gate-emitter charge	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}, V_{GE} = 15 \text{ V}$	-	TBD	-	nC
Q_{gc}	Gate-collector charge	uL -	-	TBD	-	nC

Table 6. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CE} = 400 \text{ V}, I_{C} = 30 \text{ A},$ $R_{G} = 10 \Omega, V_{GE} = 15 \text{ V}$	-	TBD TBD TBD	-	ns ns A/µs
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CE} = 400 \text{ V}, I_{C} = 30 \text{ A},$ $R_{G} = 10 \Omega, V_{GE} = 15 \text{ V}$ $T_{J} = 125 ^{\circ}\text{C}$	1	TBD TBD TBD	1	ns ns A/µs
$t_r(V_{off})$ $t_{d(off)}$ t_f	Off voltage rise time Turn-off delay time Current fall time	$V_{CE} = 400 \text{ V}, I_{C} = 30 \text{ A},$ $R_{G} = 10 \Omega, V_{GE} = 15 \text{ V}$	-	TBD TBD TBD	-	ns ns ns
$t_r(V_{off})$ $t_d(_{off})$ t_f	Off voltage rise time Turn-off delay time Current fall time	$V_{CE} = 400 \text{ V}, I_{C} = 30 \text{ A},$ $R_{G} = 10 \Omega, V_{GE} = 15 \text{ V}$ $T_{J} = 125 ^{\circ}\text{C}$	-	TBD TBD TBD	-	ns ns ns

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Table 7. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Eon ⁽¹⁾	Turn-on switching losses	V 400 V I 20 A		TBD		mJ
E _{off} (2)	Turn-off switching losses	$V_{CE} = 400 \text{ V}, I_{C} = 30 \text{ A},$ $R_{G} = 10 \Omega, V_{GF} = 15 \text{ V}$	-	0.5	-	mJ
E _{ts}	Total switching losses	ng = 10 12, vgE = 15 v		TBD		mJ
Eon ⁽¹⁾	Turn-on switching losses	$V_{CE} = 400 \text{ V}, I_{C} = 30 \text{ A},$		TBD		mJ
E _{off} (2)	Turn-off switching losses	$R_G = 10 \Omega$, $V_{GE} = 15 V$	-	0.7	-	mJ
E _{ts}	Total switching losses	T _J = 125 °C		TBD		mJ

Eon is the turn-on losses when a typical diode is used in the test circuit in Figure 2. If the IGBT is offered in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs and diode are at the same temperature (25 °C and 125 °C).

Table 8. Collector-emitter diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _F	Forward on-voltage	I _F = 16 A I _F = 16 A, T _J = 125 °C	-	TBD 1.3	2.2	V V
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_F = 16 \text{ A}, V_R = 400 \text{ V},$ $di/dt = 100 \text{ A}/\mu\text{s}$	-	TBD TBD TBD		ns nC A
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _F = 16 A,V _R = 400 V, di/dt = 100 A/µs, T _J =125 °C	-	150 330 5	-	ns nC A

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^{2.} Turn-off losses include also the tail of the collector current.

3 Test circuits

Figure 2. Test circuit for inductive load switching

Figure 3. Gate charge test circuit

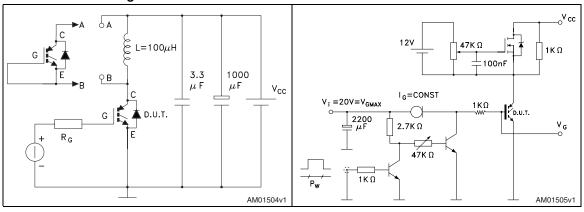
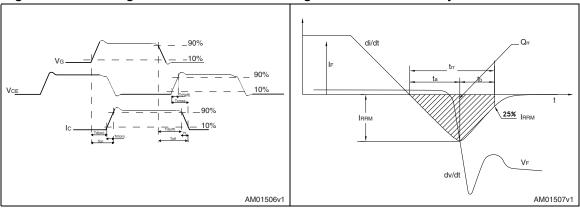


Figure 4. Switching waveform

Figure 5. Diode recovery time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 9. TO-220 type A mechanical data

Dim.		mm	
Dilli.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

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Table 10. D2PAK mechanical data

	TAX mediamodi data	mm				
Dim.	Min.	Тур.	Max.			
Α	4.40		4.60			
A1	0.03		0.23			
b	0.70		0.93			
b2	1.14		1.70			
С	0.45		0.60			
c2	1.23		1.36			
D	8.95		9.35			
D1	7.50					
E	10		10.40			
E1	8.50					
е		2.54				
e1	4.88		5.28			
Н	15		15.85			
J1	2.49		2.69			
L	2.29		2.79			
L1	1.27		1.40			
L2	1.30		1.75			
R		0.4				
V2	0°		8°			

SEATING PLANE

COPLAMARITY A1

QUEEN PLANE

CAUGE PLANE

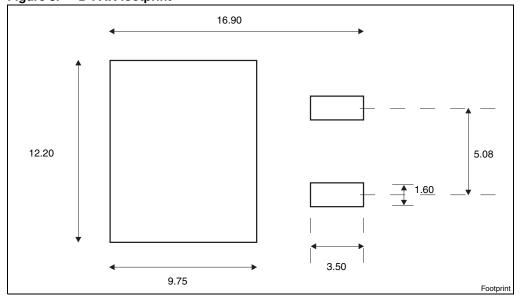
QUEEN PLANE

Figure 7. D²PAK drawing

Table 11. D²PAK tape and reel mechanical data

	Таре			Reel	
Dim	mm		Dim	m	ım
Dim.	Min.	Max.	— Dim.	Min.	Max.
A0	10.5	10.7	Α		330
В0	15.7	15.9	В	1.5	
D	1.5	1.6	С	12.8	13.2
D1	1.59	1.61	D	20.2	
Е	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	Т		30.4
P0	3.9	4.1			
P1	11.9	12.1		Base qty	1000
P2	1.9	2.1		Bulk qty	1000
R	50				
Т	0.25	0.35			
W	23.7	24.3			

D²PAK footprint^(a) Figure 8.



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a. All dimension are in millimeters

Figure 9. Tape

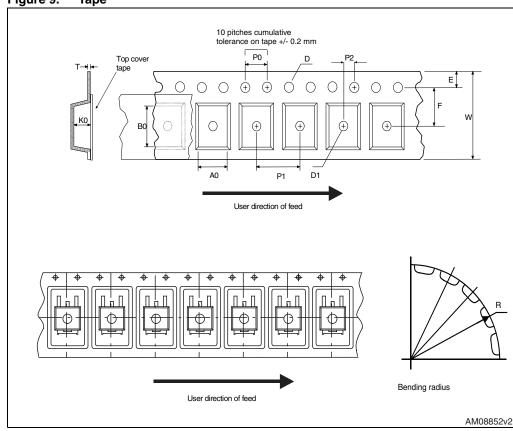
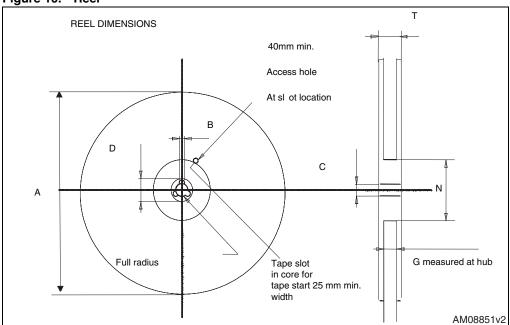


Figure 10. Reel



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5 Revision history

Table 12. Document revision history

Date	Revision	Changes
14-Oct-2011	1	Initial release.

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